1 SUMMARY OF STANDARDS AND RESULTS

1.1 Description of Standards and Results

The EUT have been tested according to the applicable standards as referenced below:

EMISSION							
Description of Test Item	Standard	Limits	Results				
Conducted Disturbance at the Mains Terminal	EN 55022:2010 (CISPR 22:2008)	Class B	Pass				
Conducted Common Mode Disturbance at Telecommunication Port	EN 55022:2010 (CISPR 22:2008)	N/A	N/A				
Radiated Disturbance	EN 55022:2010 (CISPR 22:2008)	Class B	Pass				
Harmonic Current Emission	EN 61000-3-2: 2006+A2:2009 (IEC 61000-3-2:2005+A2:2009)	N/A	N/A				
Voltage Fluctuations and Flicker	EN 61000-3-3:2008 (IEC 61000-3-3:2008)	Section 5	Pass				
	IMMUNITY (EN 55024:2010) (CISPR 24:2010)						
Description of Test Item	Basic Standard	Performance Criteria	Results				
Electrostatic Discharge (ESD)	IEC 61000-4-2:2008	В	Pass				
Radio-frequency, Continuous Radiated Disturbance	IEC 61000-4-3:2010	A	Pass				
Electrical Fast Transient (EFT)	IEC 61000-4-4:2004+A1:2010	В	Pass				
Surge	IEC 61000-4-5:2005	В	Pass				
Radio-frequency, Continuous Conducted Disturbance	IEC 61000-4-6:2008	А	Pass				
Power Frequency Magnetic Field	IEC 61000-4-8:2009	A	Pass				
Voltage Dips, >95%Reduction		В	Pass				
Voltage Dips, 30% Reduction	IEC 61000-4-11:2004	С	Pass				
Voltage Interruptions		С	Pass				

1.2 Description of Performance Criteria

The variety and the diversity of the apparatus within the scope of this standard make it difficult to define precise criteria for the evaluation of the immunity test results.

If, as result of the application of the tests defined in this standard, the apparatus becomes dangerous or unsafe, the apparatus shall be deemed to have failed the test.

A functional description and a definition of performance criteria, during or as a consequence of the EMC testing, shall be provided by the manufacturer and noted in the test report, based on the following criteria:

1.2.1 Performance criterion A

The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.

Particular performance criteria for data display equipment:

When seen from the normal viewing distance, the EUT shall operate with no change beyond the manufacturer's specification, in flicker, color, focus and jitter.

1.2.2 Performance criterion B

The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is allowed however. No change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.

Particular performance criteria for data display equipment:

Screen disturbances during the application of the test are permissible.

1.2.3 Performance criterion C

Temporary loss of function is allowed, provided the function is selfrecoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

Particular performance criteria for data display equipment:

Failures which are not self-recovered after removal of the external disturbance, but which can be recovered to normal operation by reset or reboot are permissible.

2 GENERAL INFORMATION

2.1 Description of EUT

Description : Switching Power Supply

	AK25W-SSM-5	AK25W -SSM-7.5	AK25W -SSM-9
Model No.:	AK25W-SSM-12	AK25W -SSM-13.8	AK25W -SSM-15
Widdel No	AK25W -SSM-18	AK25W -SSM-24	AK25W -SSM-27
	AK25W -SSM-28	AK25W -SSM-36	AK25W -SSM-48
	E1207849-02/03		
Serial No.:			
Sella No		E1207849-03/03	
			E1207849-01/03
Note #1 tested	: AK25W -SSM-5, A and recorded in this	AK25W -SSM-24 and A s report.	K25W -SSM-48 were
Input	: Model Number	AC Ing	out
	AK25W -SSM- AK25W -SSM-2 AK25W -SSM-4	100V-240V (8 50/60F	,
Output	: Model Number	DC Out	nut
o wip wi	AK25W -SSM-		0A
	AK25W -SSM-2		.1A
	AK25W -SSM-4		57A
Output Toloron oo			
Output Tolerance	: ±2% for AK25W -\$ ±1% for AK25W -\$	SSM-5 SSM-24 & AK25W -SS	M-48
Real Power			M-48
-	±1% for AK25W -\$	SSM-24 & AK25W -SS Real Power	M-48
-	±1% for AK25W -s	SSM-24 & AK25W -SS Real Power 5 31.3W	M-48

2.2 Load

Model Number	Full Load (Ω)	Half Load (Ω)
AK25W -SSM-5	1.00	2.00
AK25W -SSM-24	21.81	43.62
AK25W -SSM-48	84.21	168.42

2.3 Description of Test Facility

Name of Firm	:	Audix Technology (Shanghai) Co., Ltd.
Site Location	:	3F 34Bldg 680 Guiping Rd, Caohejing Hi-Tech Park, Shanghai 200233, China
Accredited by NVLAP, Lab Code	:	200371-0

2.4 Measurement Uncertainty

Conducted Emission Expanded Uncertainty:	U = 3.42 dB
Radiated Emission Expanded Uncertainty (30-200MHz):	U = 4.14 dB (Horizontal)
	U = 4.28 dB (Vertical)
Radiated Emission Expanded Uncertainty (200M-1GHz):	U = 4.18 dB (Horizontal)
	U = 4.26 dB (Vertical)

3 TEST EQUIPMENT

3.1 For Conducted Disturbance Test

Item	Туре	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
1.	Test Receiver	R&S	ESCI	100841	Mar 22, 2012	Mar 22, 2013
2.	Artificial Mains Network (AMN)	R&S	ESH2-Z5	843890/011	Feb 13, 2012	Feb 13, 2013
3.	50Ω Coaxial Switch	Anritsu	MP59B	6200426389	Mar 18, 2012	Sep 18, 2012
4.	Software	Audix	E3	SET00200 9804M592		

3.2 For Radiated Disturbance Test

Item	Туре	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
1.	Test Receiver	R&S	ESVS10	844594/001	Mar 22, 2012	Mar 22, 2013
2.	Preamplifier	Agilent	8447D	2944A10548	Mar 18, 2012	Sep 18, 2012
3.	Bi-log Antenna	TESEQ	CBL6112D	23192	Dec 01, 2011	Dec 01, 2012
4.	Spectrum	Agilent	E7405A	MY45106600	Mar 22, 2012	Mar 22, 2013
5.	50Ω Coaxial Switch	Anritsu	MP59B	6200426389	Mar 18, 2012	Sep 18, 2012
6.	Software	Audix	E3	SET00200 9912M295-2		

3.3 For Voltage Fluctuations and Flicker Test

Item	Туре	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
1.	AC Source	CI	5001IX	58478	Mar 22, 2012	Mar 22, 2013
2.	Power Analyzer	CI	PACS-1	72626	Mar 22, 2012	Mar 22, 2013
3.	Software	CI	CTS 3.0	Version 3.2.0.32		

3.4 For Electrostatic Discharge Immunity Test

Item	Туре	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
1.	ESD Simulator	TESEQ	NSG 437	130	Dec 05, 2011	Dec 05, 2012
2.	Digital Multimeter	Agilent	34401A	MY41050690	Mar 22, 2012	Mar 22, 2013

Item	Туре	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
1.	Signal Generator	Agilent	E4421B	MY 43350935	Mar 22, 2012	Mar 22, 2013
2.	Power Amplifier	AR	KAW 2180	10088-1	Mar 22, 2012	Mar 22, 2013
3.	Log-Periodic Antenna	AR	AT1080	19300	Jan 30, 2012	Jan 30, 2013
4.	Dual Directional Coupler (DDC)	AR	DC6180	19326	Mar 18, 2012	Sep 18, 2012
5.	Power Meter	HP	438A	2517A02731	Mar 22, 2012	Mar 22, 2013
6.	Power Sensor	HP	8481D	3318A13765	Apr 06, 2012	Apr 06, 2013
7.	Field Monitor	AR	FM2000	19221	NCR	NCR
8.	Field Probe	AR	FP2036	308920	May 19, 2012	May 19, 2013
9.	Digital Multimeter	Agilent	34401A	MY41050690	Mar 22, 2012	Mar 22, 2013

3.5 For RF Electromagnetic Field Immunity Test

3.6 For Electrical Fast Transient/Burst Immunity Test

Item	Туре	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
1.	EFT Generator	Prima	EFT61004A	PR11034301	Jul 08, 2012	Jul 08, 2013
2.	Digital Multimeter	Agilent	34401A	MY41050690	Mar 22, 2012	Mar 22, 2013

3.7 For Surge Immunity Test

Item	Туре	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
1.	Surge Generator	Prima	SUG61005B	PR11065349	Jul 06, 2012	Jul 06, 2013
2.	Digital Multimeter	Agilent	34401A	MY41050690	Mar 22, 2012	Mar 22, 2013

3.8 For Conducted Disturbances Immunity Test

Item	Туре	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
1.	Signal Generator	HP	8648A	3636A02166	Mar 18, 2012	Sep 18, 2012
2.	Coupling Decoupling Network (CDN)	FCC	FCC-801-M3- 25	105	Mar 22, 2012	Mar 22, 2013
3.	Power Amplifier	AR	100A250	19367	Mar 22, 2012	Mar 22, 2013
4.	Attenuator	HP	40-6-34	LJ094	Mar 18, 2012	Sep 18, 2012
5.	Power Meter	HP	438A	2517A02731	Mar 22, 2012	Mar 22, 2013
6.	Power Sensor	HP	8482B	3318A06358	Mar 22, 2012	Mar 22, 2013
7.	Digital Multimeter	Agilent	34401A	MY41050690	Mar 22, 2012	Mar 22, 2013

3.9 For Power Frequency Magnetic Field Immunity Test

Item	Туре	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
1.	p-f Magnetic Field Loop	FCC	F-1000-4-8/9/1 0-1M	13	Mar 22, 2012	Mar 22, 2013
2.	EMC Immunity test system	KeyTek	CE Master	9609367	Mar 22, 2012	Mar 22, 2013
3.	Digital Multimeter	Agilent	34401A	MY41050690	Mar 22, 2012	Mar 22, 2013

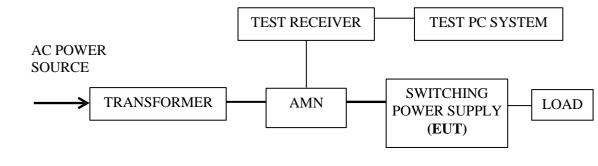
3.10 For Voltage Dips and Short Interruptions Immunity Test

Item	Туре	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
1.	EMC Immunity test system	KeyTek	CE Master	9609367	Mar 22, 2012	Mar 22, 2013
2.	Digital Multimeter	Agilent	34401A	MY41050690	Mar 22, 2012	Mar 22, 2013

4 CONDUCTED DISTURBANCE TEST

4.1 Block Diagram of Test Setup

4.1.1 Conducted Disturbance Test Setup



_ : Signal Line

- : Power Line

4.2 Applicable Standard

EN 55022:2010 (CISPR 22:2008) (Class B)

4.3 Limits for Conducted Disturbance

Frequency Range	Limits dB (µV)			
(MHz)	Quasi-peak	Average		
0.15 ~ 0.5	66~56	56~46		
0.5 ~ 5	56	46		
5 ~ 30	60	50		
 NOTE 1 - The lower limit shall apply at the transition frequencies. NOTE 2 - The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz~0.50 MHz NOTE 3 - If the average limit is met when using a quasi-peak detector, the EUT shall be deemed to meet both limits and measurement with the average detector is unnecessary. 				

4.4 EUT Configuration

The EUT and the peripherals were installed as shown on Sec.4.1.1. in Conducted Disturbance Test to meet EN 55022:2010 (CISPR 22:2008) (Class B) requirement and operating in a manner which tends to maximize its disturbance level in a normal application.

4.5 Operating Condition of EUT

- 4.5.1 Set up the EUT as shown in Sec.4.1.
- 4.5.2 Turn on the power of all equipments.
- 4.5.3 Turn on the power of EUT.
- 4.5.4 Set the EUT on the test modes, and then test.

4.6 Test Procedure

The EUT was placed upon a non-metallic table, which is 0.8 m above the horizontal conducting ground plane and 0.4 m from a vertical reference plane. The EUT was connected to the power mains through an Artificial Mains Network (AMN) to provide a 50 \land coupling impedance for the measuring equipment. Both sides of AC line (Line & Neutral) were checked to find out the maximum conducted emission according to EN 55022:2010 regulations during conducted disturbance test.

The IF bandwidth of R & S Test Receiver ESCI was set at 9 kHz.

The frequency range from 150 kHz to 30 MHz was checked.

The test mode (Full Load and Half Load) were done on conducted disturbance test and all the test results are listed in Sec. 4.7.

4.7 Test Results

<PASS>

The frequency range is swept from 150 kHz to 30 MHz.

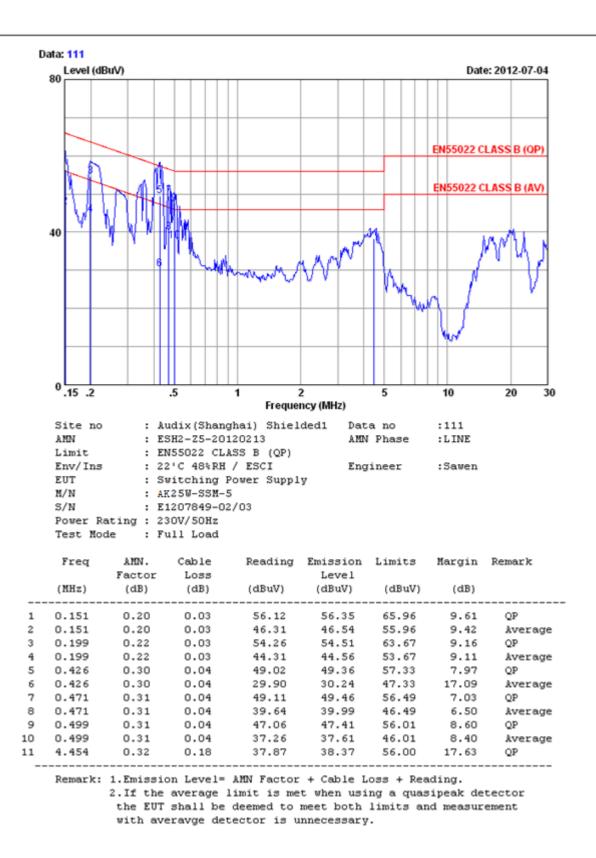
All the following records are the disturbance levels and the frequencies of the highest disturbances, and if the emissions not reported below are too low against the prescribed limits.

Model Number	Test Mode	Data Page
AK25W -SSM-5	Full Load	P15 – P16
AR25 W -5514-5	Half Load	P17 – P18
AK25W -SSM-24	Full Load	P19 - P20
AK23W -55M-24	Half Load	P21 – P22
AK25W -SSM-48	Full Load	P23 – P24
AK23W -55M-48	Half Load	P25 – P26

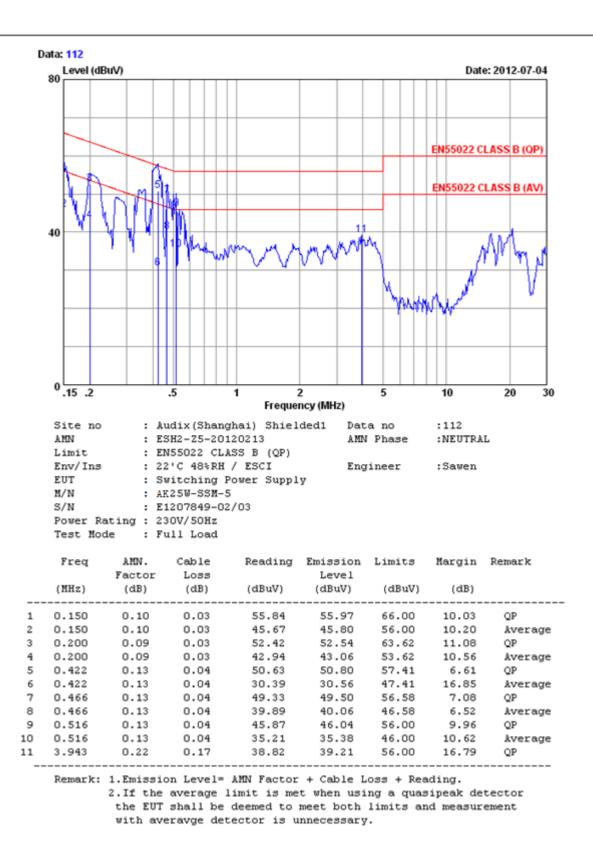
NOTE 1 – "QP" means "Quasi-Peak" values, "AV" means "Average" values.

NOTE 2 – The worst case is for Half Load (M/N: AK25W-SSM-5) test mode. The worst emission is detected at 0.413 MHz (Quasi-Peak Value) with corrected signal level of 52.04 dB (μV) (limit is 57.59 dB (μV)), when the Line of the EUT is connected to AMN.

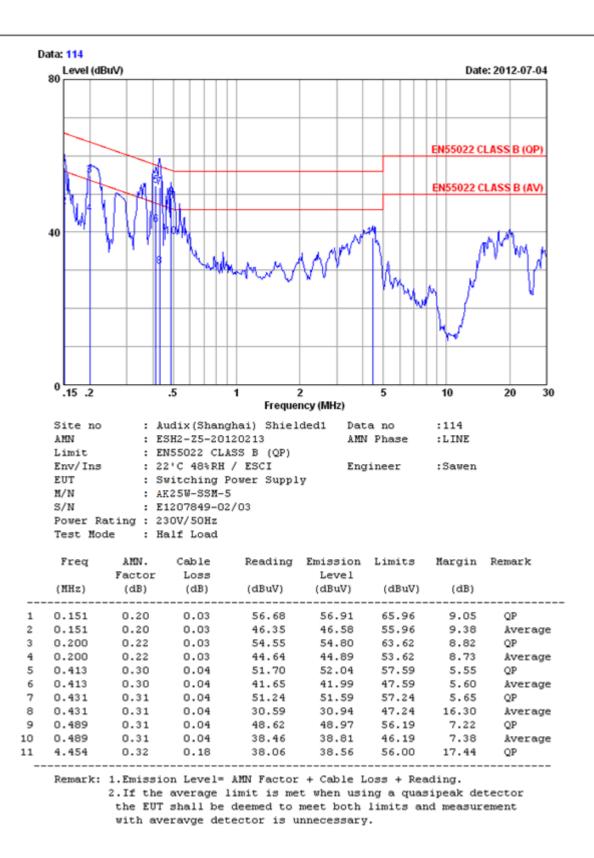




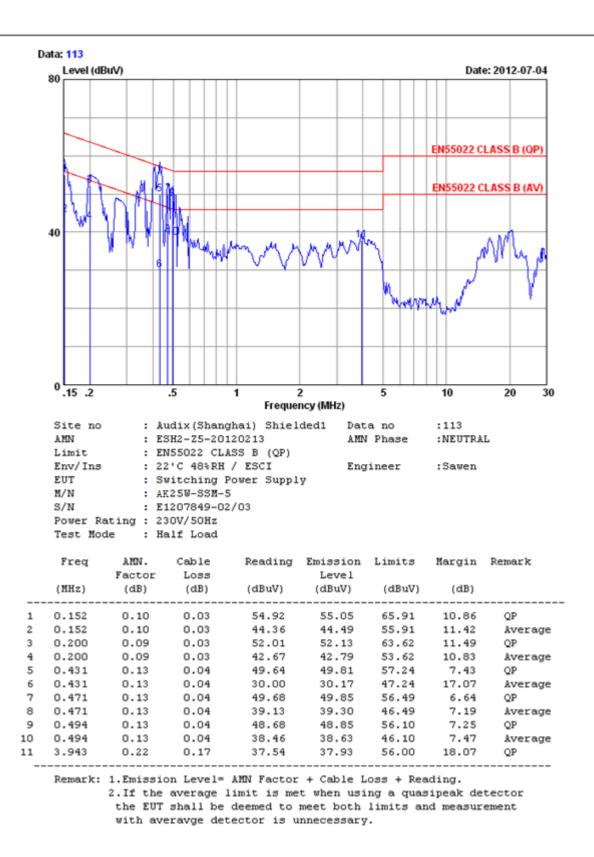




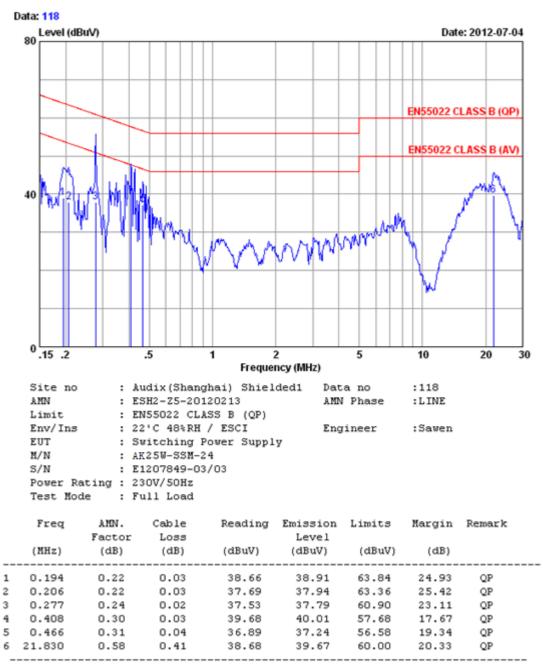








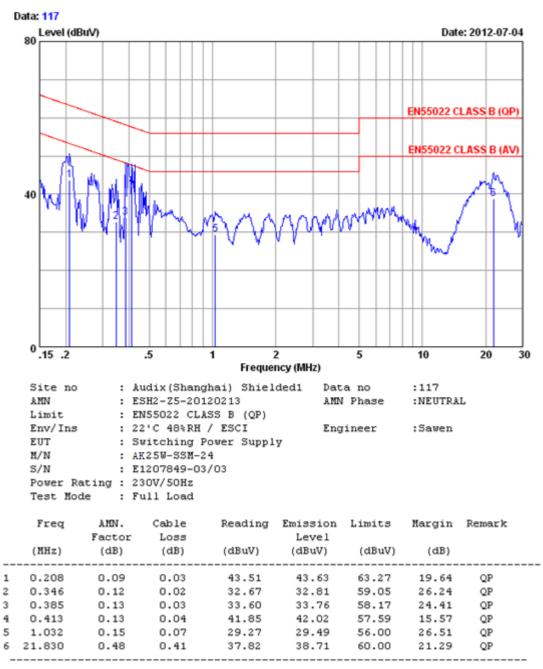




Remark: 1.Emission Level= &MN Factor + Cable Loss + Reading.

2.If the average limit is met when using a quasipeak detector the EUT shall be deemed to meet both limits and measurement with averavge detector is unnecessary.

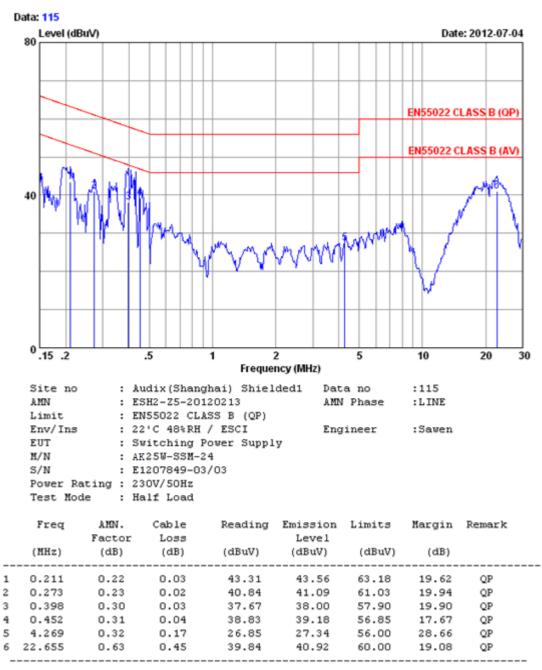




Remark: 1.Emission Level= AMN Factor + Cable Loss + Reading.

2.If the average limit is met when using a quasipeak detector the EUT shall be deemed to meet both limits and measurement with averavge detector is unnecessary.

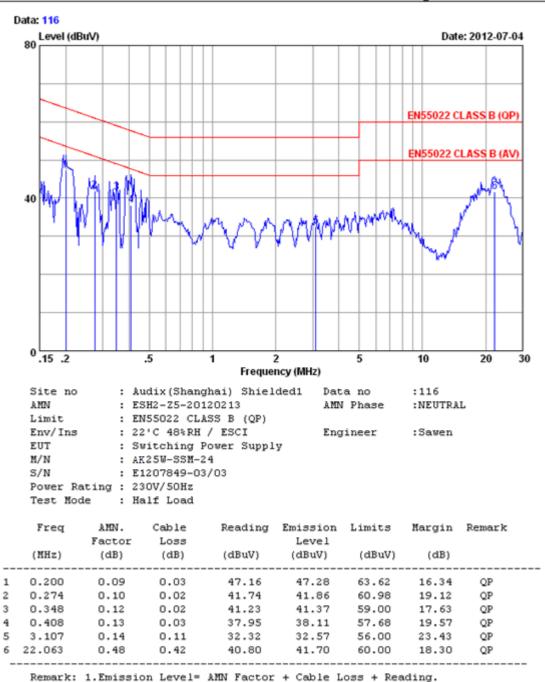




Remark: 1.Emission Level= AMN Factor + Cable Loss + Reading.

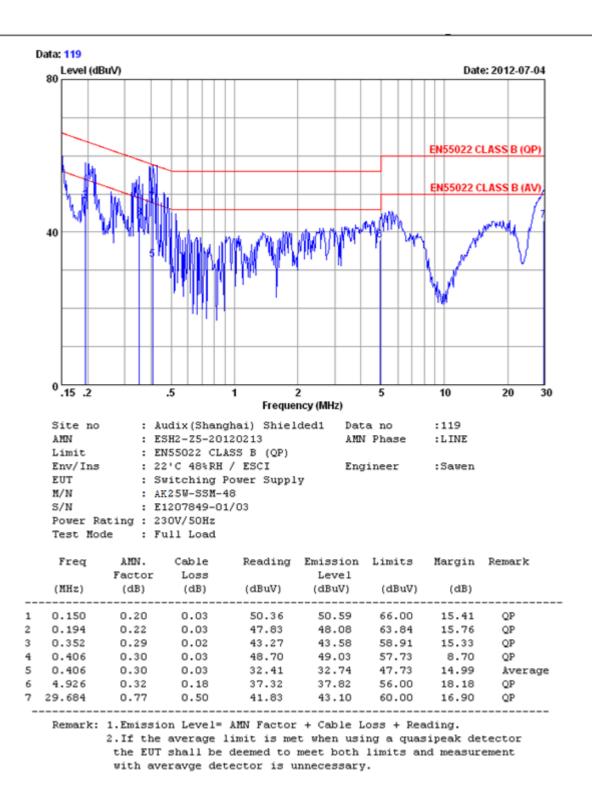
2.If the average limit is met when using a quasipeak detector the EUT shall be deemed to meet both limits and measurement with averavge detector is unnecessary.



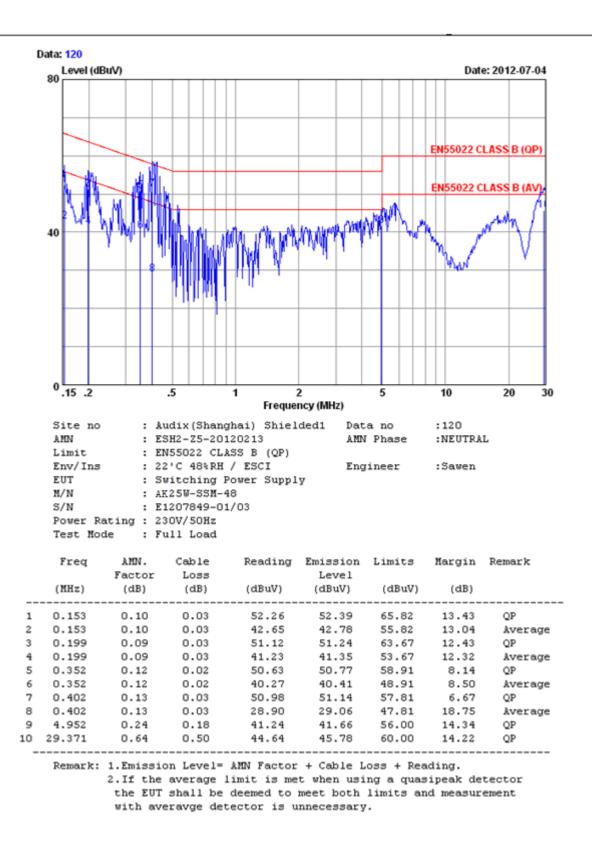


K: 1.Emission Level= KNN Factor + Cable Loss + Reading.
2. If the average limit is met when using a quasipeak detector the EUT shall be deemed to meet both limits and measurement with average detector is unnecessary.

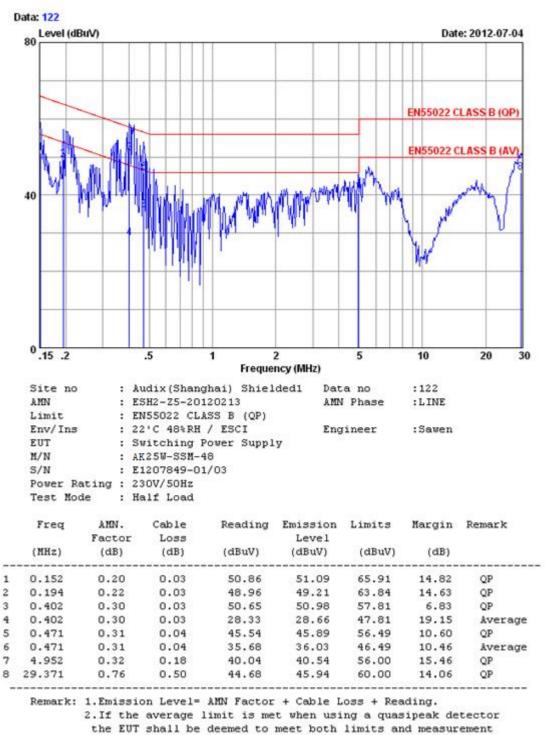






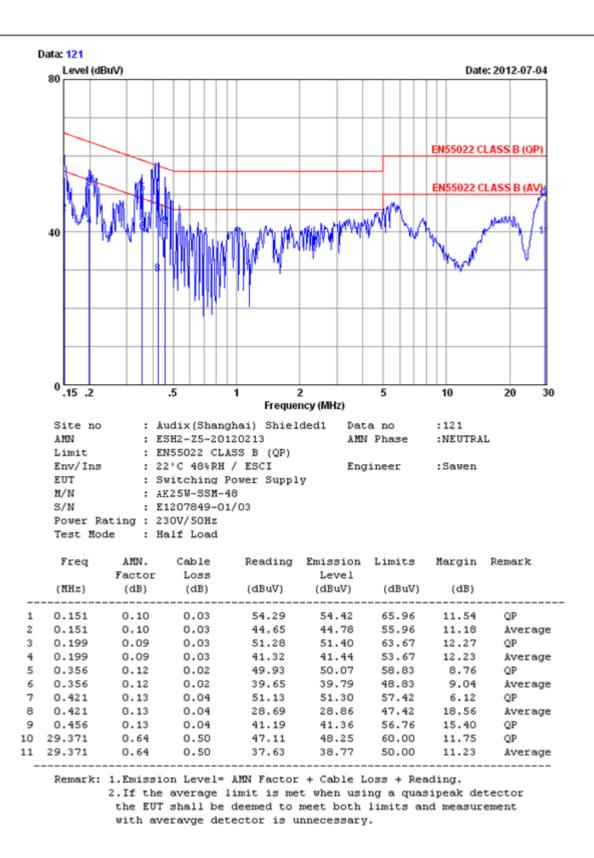






with averavge detector is unnecessary.

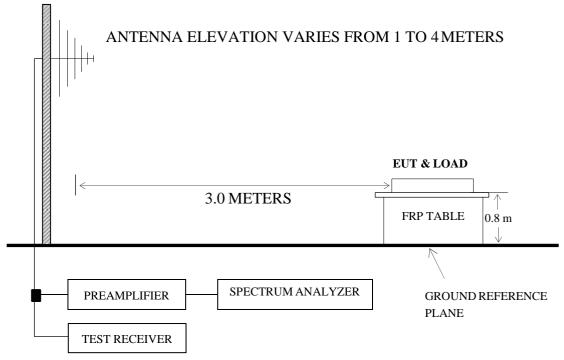




5 RADIATED DISTURBANCE TEST

5.1 Block Diagram of Test Setup

5.1.1 Radiated emission test setup



■ : 50 ohm Coaxial Switch

5.2 Applicable Standard

EN 55022:2010 (CISPR 22:2008) (Class B)

5.3 Limits for Radiated Disturbance

All emanations from a Class B devices or system of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified below:

	,		6 1	
Frequency	Distance	Field Strength Limits	Converted Field Strength Limits By 3 Meters Measuring Distance	
(MHz)	(m)	$dB(\mu V/m)$	$dB(\mu V/m)$	
30 ~ 230	10	30	40	
230 ~ 1000 10		37	47	
 NOTE 1 - The tighter limit applies at the edge between two frequency bands. NOTE 2 - Distance refers to the distance in meters between the measuring instrument antenna and the closed point of any part of the device or system. 				
NOTE 3 - Audix Technology (Shanghai) Co., Ltd. Only has a 3 meters Semi-anechoic Chamber to do the radiated test, therefore, Audix Shanghai used 3 meters measuring distance and converted limits to judge the EUT compliance with or not.				

5.4 EUT Configuration

The configuration of the EUT is same as those used in conducted disturbance test.

Refer to Sec.4.4.

5.5 Operating Condition of EUT

Same as conducted disturbance test which is listed in Sec.4.5, except for the test setup replaced by Sec.5.1.1.

5.6 Test Procedure

The EUT and the peripherals were placed upon a FRP turntable 0.8 m above the horizontal metal ground plane. The FRP turntable rotated 360 degrees to determine the position of the maximum emission level. The EUT was set 3 meters away from the receiving antenna that was mounted on an antenna tower. The antenna moved up and down between 1 meter and 4 meters to find out the maximum emission level. Broadband antenna (Calibrated Bilog Antenna) or dipole antenna was used as receiving antenna. Both horizontal and vertical polarizations of the antenna were set on measurement. In order to find the maximum emission, all of the interface cables were manipulated according to EN 55022 requirements during radiated test.

The IF bandwidth of R&S Test Receiver ESVS10 was set at 120 kHz.

The frequency range from 30 MHz to 1000 MHz was checked.

The test mode (Full Load and Half Load) were done on radiated disturbance test and all the test results are listed in Sec.5.7.

5.7 Test Results

<PASS>

All the following records are the disturbance levels and the frequencies of the highest disturbances, and if the disturbance not reported below are too low against the limits.

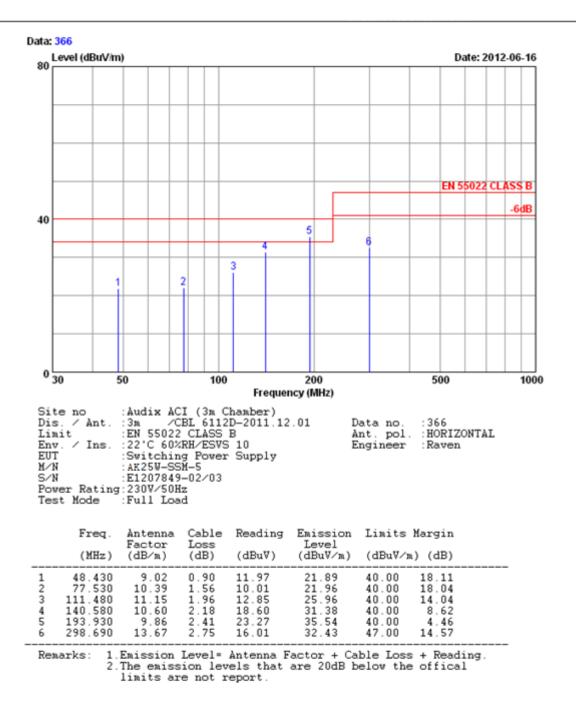
Model Number	Test Mode	Data Page
AK25W-SSM-5	Full Load	P30 – P31
AK23 W-35W-3	Half Load	P32 - P33
AK25W-SSM-24	Full Load	P34 – P35
AK23 W-551VI-24	Half Load	P36 – P37
AK25W-SSM-48	Full Load	P38 – P39
AK23 W-55W-40	Half Load	P40 – P41

Refer to the following pages.

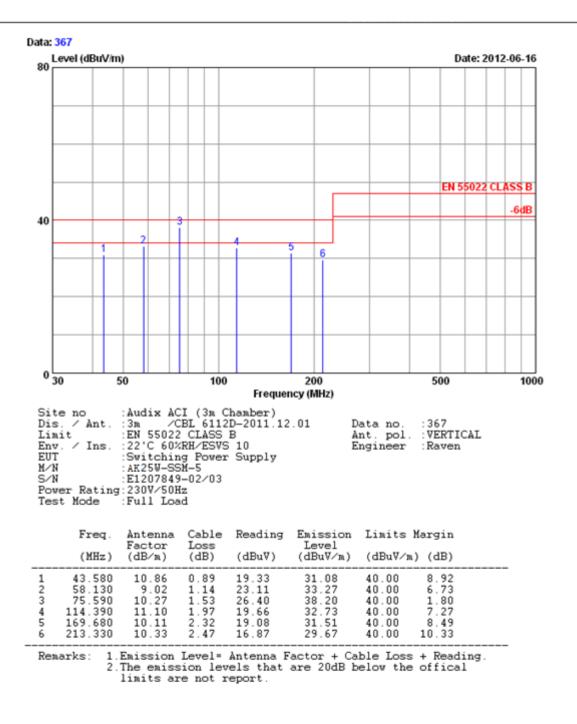
NOTE 1 – All reading are Quasi-Peak values.

- NOTE $2 0^{\circ}$ was the table front facing the antenna. Degree is calculated from 0° clockwise facing the antenna.
- NOTE 3 The worst case is for Half Load (M/N: AK25W-SSM-5) test mode. The worst emission at horizontal polarization was detected at 187.140 MHz with corrected signal level of 34.09 dB (μ V/m) (limit is 40.00 dB (μ V/m)), when the antenna was 1.10 m height and the turntable was at 140°. The worst emission at vertical polarization was detected at 77.530 MHz with corrected signal level of 38.58 dB (μ V/m) (limit is 40.00 dB (μ V/m)), when the antenna was 1.00 m height and the turntable was at 293° clockwise facing the antenna.

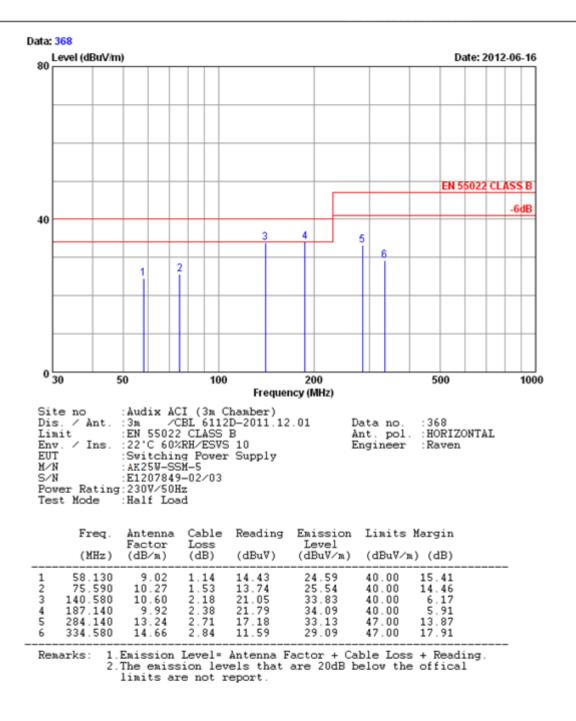




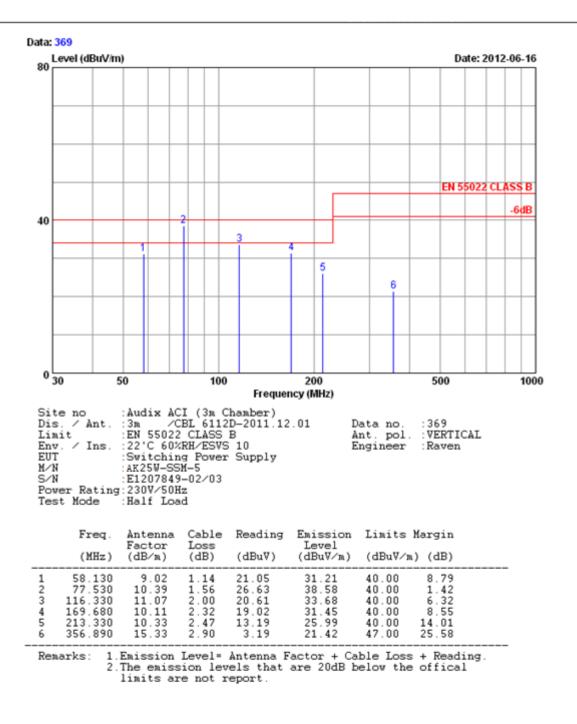




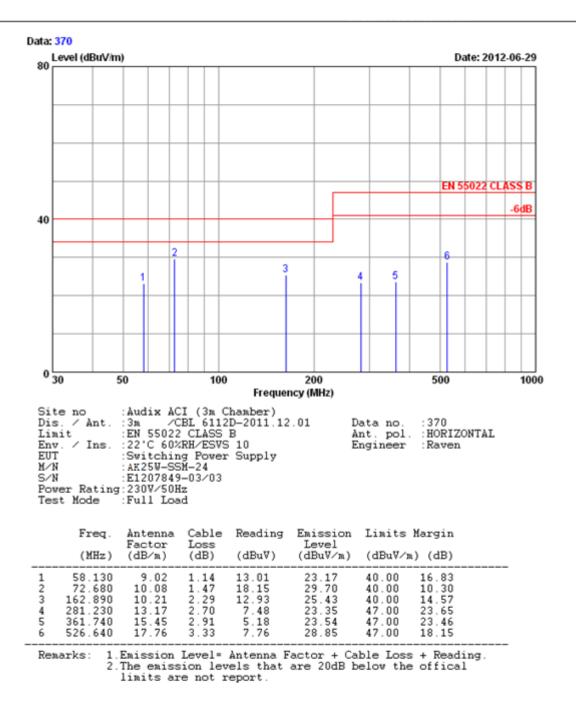




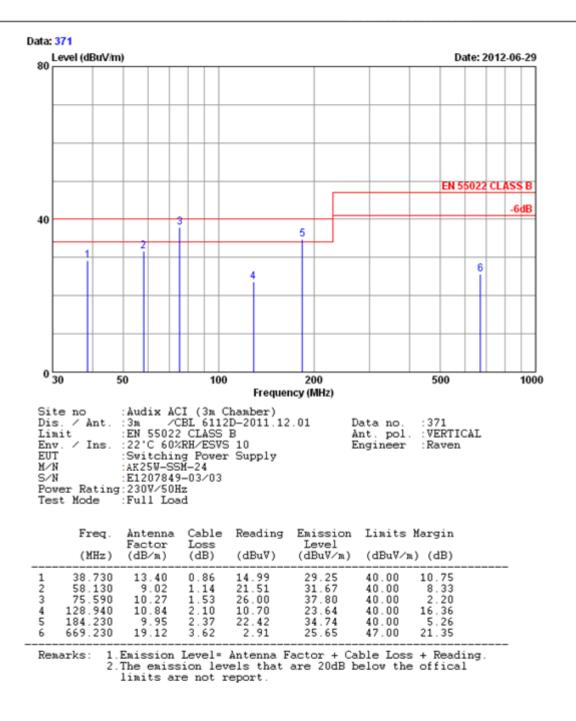




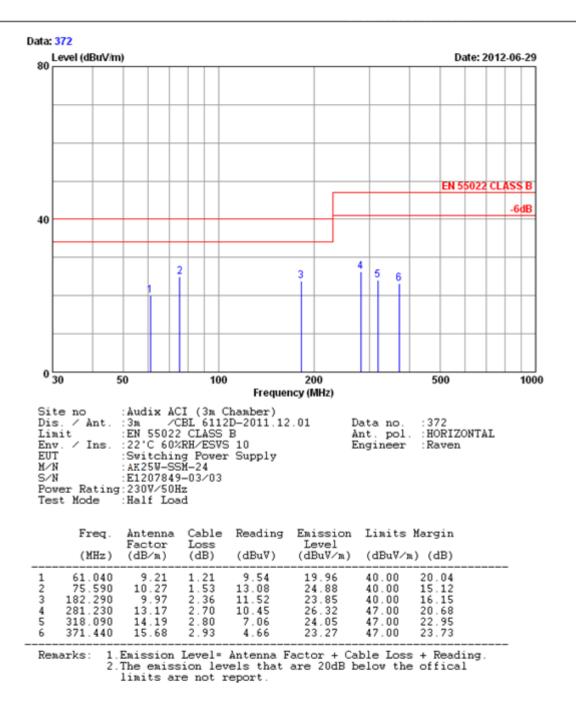




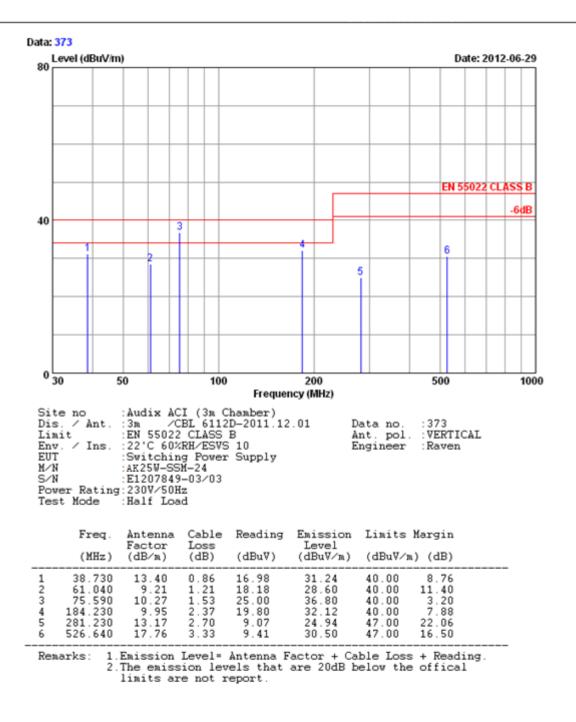




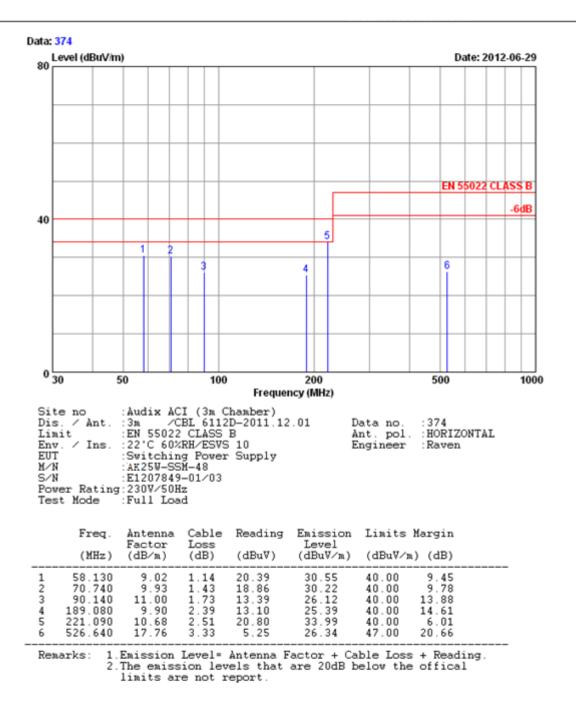




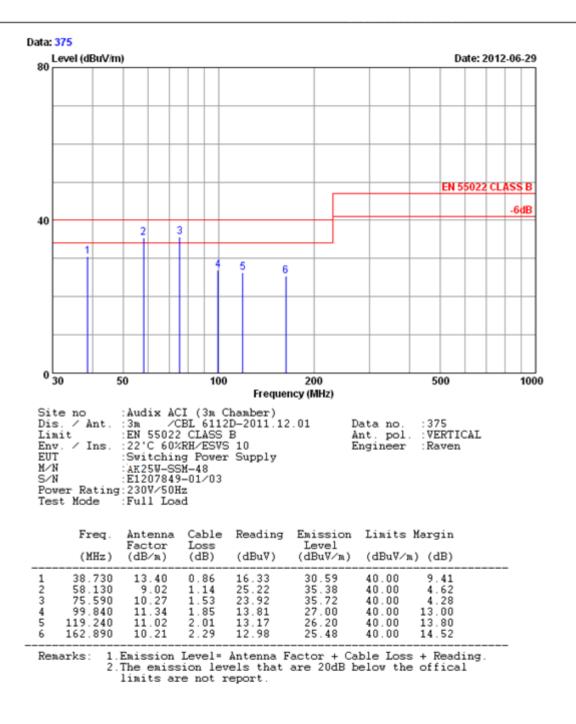




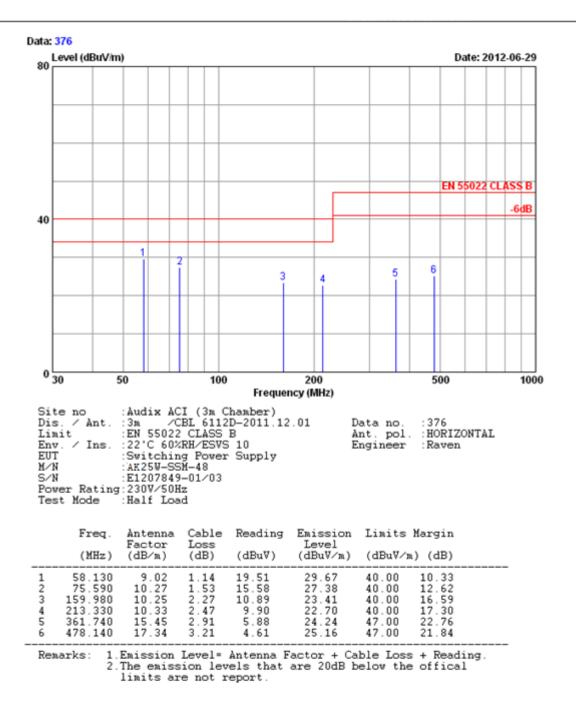




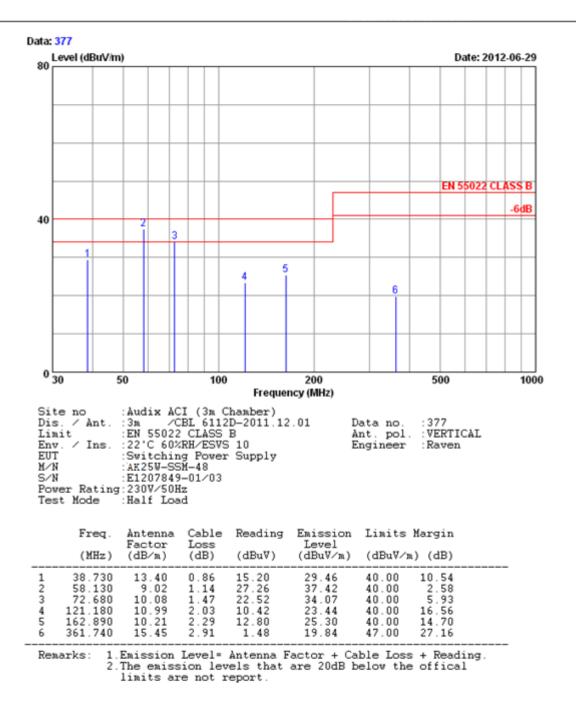








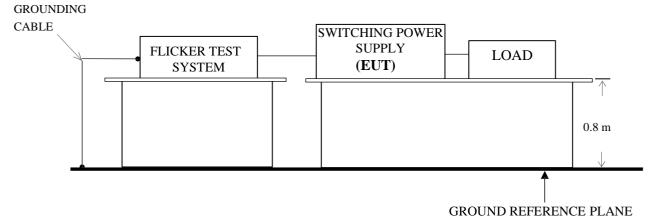




6 VOLTAGE FLUCTUATIONS AND FLICKER TEST

6.1 Block Diagram of Test Setup

6.1.1 Voltage Fluctuations and Flicker test setup



6.2 Applicable Standard

EN 61000-3-3:2008 (IEC 61000-3-3:2008)

6.3 Voltage Fluctuations and Flicker Emission Limits

Corresponding limits for each flicker are listed in following data sheets.

6.4 EUT Configuration

The configuration of the EUT is same as Sec. 4.4.except the test setup replaced by Sec.6.1.

The EUT power was supplied by flicker test system.

6.5 Operating Condition of EUT

- 6.5.1 Setup the EUT and the peripherals in shielded room as Sec 6.1 and operate them as 4.5.
- 6.5.2 The test system analyzed the flicker.
- 6.5.3 Read the values and recorded them.

6.6 Test Procedure

Refer to Sec. 4.6.

6.7 Test Results

<PASS>

Test results refer to the following pages.

Flicker Test Summary per EN/IEC61000-3-3 (Run time)

EUT: Switching Power SupplyTestTest category: dt,dmax,dc and Pst (European limits)TestTest date: 2012-7-11Start time: 20:00:20EndTest duration (min): 10Data file name: F-000068.cts_dataComment: AK25W-SSM-5

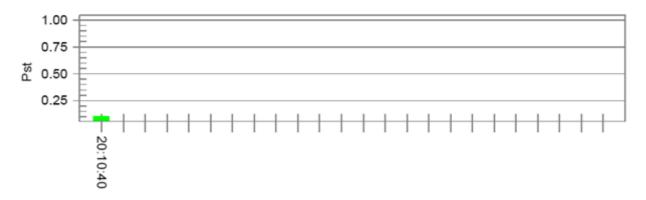
Tested by: Lvy Test Margin: 100 End time: 20:10:41

Test Result: Pass

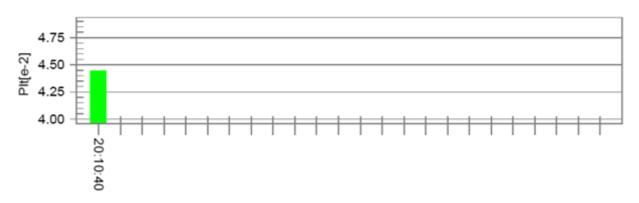
Status: Test Completed

Pst_i and limit line

European Limits



Plt and limit line



Parameter values recorded during the test:Vrms at the end of test (Volt):230.07Highest dt (%):0.62Time(mS) > dt:0.0Highest dc (%):0.00Highest dmax (%):0.61Highest Pst (10 min. period):0.102

Test limit (%):	3.30	Pass
Test limit (mS):	500.0	Pass
Test limit (%):	3.30	Pass
Test limit (%):	4.00	Pass
Test limit:	1.000	Pass

Flicker Test Summary per EN/IEC61000-3-3 (Run time)

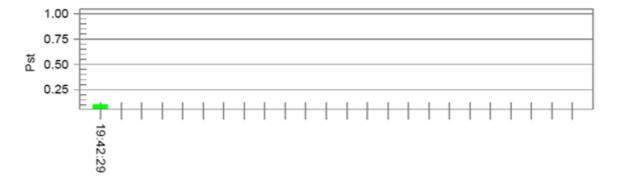
EUT: Switching Power SupplyTested by: LvyTest category: dt,dmax,dc and Pst (European limits)Test Margin: 100Test date: 2012-7-11Start time: 19:32:09End time: 19:42:30Test duration (min): 10Data file name: F-000066.cts_dataComment: AK25W-SSM-24Comment: AK25W-SSM-24

Test Result: Pass

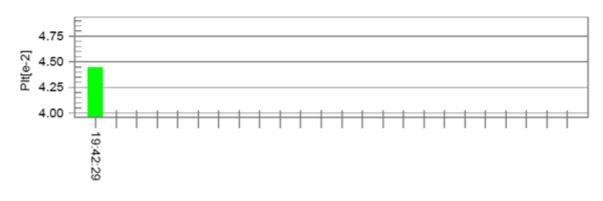
Status: Test Completed

Pst_i and limit line

European Limits



Plt and limit line



Parameter values recorded during the test:

230.12			
0.40	Test limit (%):	3.30	Pass
0.0	Test limit (mS):	500.0	Pass
0.00	Test limit (%):	3.30	Pass
0.41	Test limit (%):	4.00	Pass
0.102	Test limit:	1.000	Pass
	0.40 0.0 0.00 0.41	0.40 Test limit (%): 0.0 Test limit (mS): 0.00 Test limit (%): 0.41 Test limit (%):	0.40 Test limit (%): 3.30 0.0 Test limit (mS): 500.0 0.00 Test limit (%): 3.30 0.41 Test limit (%): 4.00

-- -

Flicker Test Summary per EN/IEC61000-3-3 (Run time)

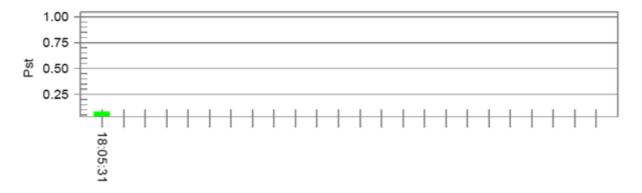
EUT: Switching Power SupplyTested by: LvyTest category: dt,dmax,dc and Pst (European limits)Test Margin: 100Test date: 2012-7-11Start time: 17:55:10End time: 18:05:32Test duration (min): 10Data file name: F-000063.cts_dataComment: AK25W-SSM-48

Test Result: Pass

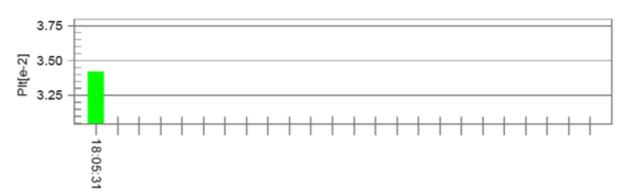
Status: Test Completed

Pst_i and limit line

European Limits



Plt and limit line



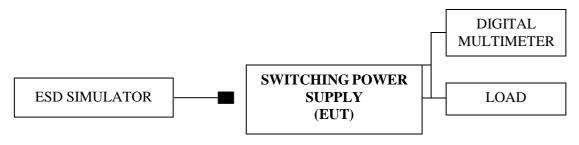
Parameter values recorded during the test:

i alameter falaee feeelaea aa	ing the teet.				
Vrms at the end of test (Volt):	230.12				
Highest dt (%):	-0.56	Test limit (%):	3.30	Pass	
Time(mS) > dt:	0.0	Test limit (mS):	500.0	Pass	
Highest dc (%):	0.00	Test limit (%):	3.30	Pass	
Highest dmax (%):	0.34	Test limit (%):	4.00	Pass	
Highest Pst (10 min. period):	0.078	Test limit:	1.000	Pass	

7 ELECTROSTATIC DISCHARGE IMMUNITY TEST

7.1 Block Diagram of Test Setup

7.1.1 Electrostatic Discharge Immunity test setup



7.2 Applicable Standard

EN 55024:2010 (CISPR 24:2010) (IEC 61000-4-2:2008, Contact Discharge: $\pm 2kV$, $\pm 4kV$, Air Discharge: $\pm 2kV$, $\pm 4kV$, $\pm 8kV$)

7.3 Severity Levels and Performance Criterion

	Test Voltage				
Level	Contact Discharge (kV)	Air Discharge (kV)			
1.	2	2			
2.	4	4			
3.	6	8			
4.	8	15			
Х	Special	Special			

7.3.1 Severity levels

7.3.2 Performance criterion: **B**

7.4 EUT Configuration

The configuration of the EUT is same as those used in conducted disturbance test. Refer to Sec. 4.4.

7.5 Operating Condition of EUT

- 7.5.1 Setup the EUT on a reference plane in a shielded room as Sec. 7.1, and operate them as Sec. 4.5.
- 7.5.2 Single discharges are applied to the horizontal and vertical coupling plane at points on each side of the EUT.
- 7.5.3 Check the effects of this test.

7.6 Test Procedure

The test applied a non-conductive surface and a horizontal coupling plane on a wooden table, 0.8 m high, standing on the reference ground plane, which is a 2 m x 3 m metallic sheet with 1.5 mm thickness. This reference ground plane projected beyond the EUT by at least 0.5 m on all sides and the minimum distance between the EUT and all other conductive structure, except the ground plane beneath the EUT, was more than 1.0 m.

7.6.1 Contact Discharge

The tip of the discharge electrode should touch the EUT, before the discharge switch was operated. The EUT shall be exposed to at least 200 discharges, 100 each at negative and positive polarity, at a minimum of four test points (a minimum of 50 discharges at each point). One of the test points shall be subjected to at least 50 indirect discharges (contact) to the center of the front edge of the horizontal coupling plane. If no direct contact test points are available, then at least 200 indirect discharges shall be applied in the indirect mode (use of the Vertical Coupling Plane)

7.6.2 Horizontal Coupling Plane (HCP)

More than 50 single discharges were applied at the front edge of each HCP opposite the center point of the EUT and 0.1mm from vertically the front of the EUT. Discharge to the HCP was made horizontal to the edge of the HCP.

7.6.3 Vertical Coupling Plane (VCP)

More than 50 single discharges were applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5 m x 0.5 m, was placed parallel to, and positioned at a distance of 0.1 m from the EUT. Discharges were applied to the coupling plane, with this plane in sufficient different positions that all sides of the EUT were completely illuminated.

7.6.4 Air Discharge

The round discharge tip of the discharge electrode was approached as fast as possible to touch the EUT. After each discharge, the ESD simulator (discharge electrode) was removed from the EUT. The simulator was then re-trigged for a new single discharge and applies more than 10 times on each reselected point. This procedure was repeated until the air discharge completed. 7.7 Test Results

<PASS>

Electrostatic Discharge Immunity Test Result

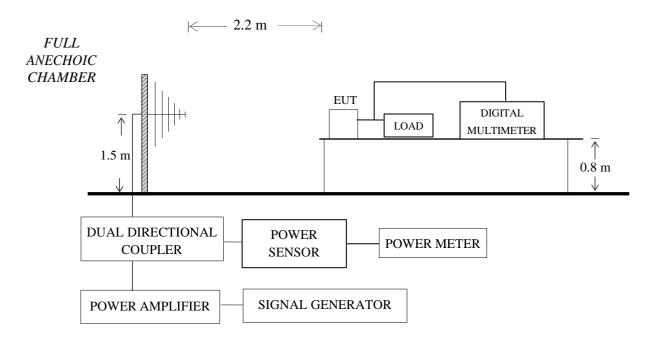
EUT :	Swit	ching Power Supply	Test Date :	Jul 12, 2012
M/N :	AK2	5W-SSM-5, 5W-SSM-24,	Temperature :	23°C
S/N :	E120 E120	<u>5W-SSM-48</u>)7849-02/03,)7849-03/03,)7849-01/03	Humidity : Atmospheric	55%RH
Power Supply :		230V/50Hz	Pressure : Test Mode :	101.3 kPa Full Load
Contact Discha	urge Vo	ltage: $\pm 2kV$; $\pm 4 kV$	Air Discharge Vo	bltage: $\pm 2 \text{ kV}$; $\pm 4 \text{ kV}$; $\pm 8 \text{ kV}$
Contact Discharge: For each point positive 25 times and negative 25 times discharge		Air Discharge: For each point positive 10 times and negative 10 times discharge		
Location		Point (s)	Kind	Result
Location Around EU	T	Point(s)	Kind C (VCP)	Result A/PASS
Around EU	Т	4	C (VCP)	A/PASS
Around EU' Around EU'	Т	4 4	C (VCP) C (HCP)	A/PASS A/PASS
Around EU' Around EU' Metal Shell Screws NOTE 1 – C (<u>C</u> or NOTE 2 – HCP (T 1 ntact D <u>H</u> orizo	4 4 6 4	C (VCP) C (HCP) C C C	A/PASS A/PASS A/PASS A/PASS A/PASS

TEST ENGINEER: LVY LV

8 RF ELECTROMAGNETIC FIELD IMMUNITY TEST

8.1 Block Diagram of Test Setup

8.1.1 RF Electromagnetic Field Immunity test setup



8.2 Applicable Standard

EN 55024:2010 (CISPR 24:2010) (IEC 61000-4-3: 2010, Frequency Range: 80 - 1000 MHz, Field Strength: 3 V/m, Modulation: 80% AM 1 kHz)

8.3 Severity Levels and Performance Criterion

8.3.1 Severity levels

Level	Field Strength V/m
1.	1
2.	3
3.	10
X	Special

8.3.2 Performance criterion: A

8.4 EUT Configuration

The configuration of the EUT is same as those used in conducted disturbance test.

Refer to Sec. 4.4.

8.5 Operating Condition of EUT

- 8.5.1 Setup the EUT on the table in an anechoic chamber as Sec. 8.1.1.
- 8.5.2 The test was performed with the transmitting antenna facing each side of the EUT.
- 8.5.3 Check the effects of the test.
- 8.6 Test Procedure

The EUT and peripherals were placed on a wooden table, 0.8 m high, standing on the ground reference plane.

The power meter was used to measure the forward power. The EUT was set 2.2 m from the transmitting antenna. Both horizontal and vertical polarization of the antenna was set on test. Each side of the EUT was faced to the transmitting antenna and measured individually.

A CCD camera was put inside the chamber and through its display to monitor the operational situation of the EUT to judge the EUT performance criterion during test.

The frequency range is swept from 80 MHz to 1000 MHz.

All the scanning conditions are as follows:

Condition of Test

Remarks ------3 V/m (Severity Level 2)

Fielded Strength Modulation Scanning Frequency Dwell Time

3 V/m (Severity Level 2) 80% AM 1 kHz 80 - 1000 MHz 3 sec.

8.7 Test Results

<PASS>

RF Field Strength Susceptibility Immunity Test Result

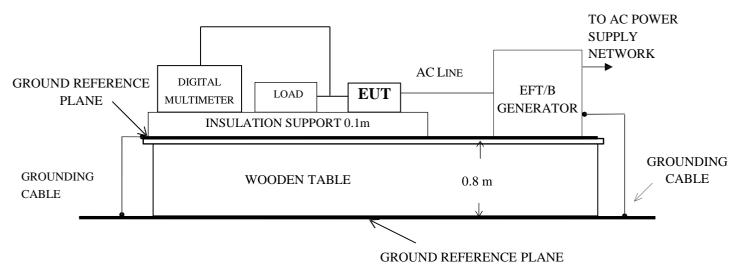
				Test l	Date :	Jul 05, 2	2012
EUT	:	Switching Power Supply		Temp	erature :	23°C	
M/N	:	AK25W-SSM-5, AK25W-SSM-24, AK25W-SSM-48		Humi	dity :	48%RI	H
S/N	:	E1207849-02/03, E1207849-03/03, E1207849-01/03		Atmo Pressi	spheric ure :	101.3	3 kPa
Power Sup	pply :	AC 230V/50Hz		Field	Strength :	<u>3 V/m</u>	L
Test Mode	e :	Full Load		Modu	lation :	□Pulse	□ AM
Frequency	Range	80 MHz to	1000 MHz			900 M	lHz
Modula	tion	80% Al	M 1 kHz				-
Step	S	1	%				
Dwell T	ime	3	3 S				
Anten Polariza		Horizontal	Vertical		Horizontal Ve		Vertical
	Front	PASS	PASS				
	Rear	PASS	PASS				
EUT	Right	PASS	PASS				
Position	Left	PASS	PASS				
	Floor	PASS	PASS				
	Тор	PASS	PASS				
NOTE 1	– ''" n	neans the item is no app	plicable.				
NOTE 2	– Durin	g the test, the output ha	as no change.				
 Test equipment: Signal Generator : Agilent E4421B Power Amplifier : AR KAW2180 Power Meter : HP 438A Log-Periodic Antenna : AR AT1080 DDC : AR DC6180 							

TEST ENGINEER: VINCENT GAO

9 ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

9.1 Block Diagram of Test Setup

9.1.1 Electrical Fast Transient/Burst Immunity test setup



9.2 Applicable Standard

EN 55024:2010 (CISPR 24:2010) (IEC 61000-4-4:2004+A1:2010, Test Value : Power Line: ±1kV, 5/50ns, 5kHz)

9.3 Severity Levels and Performance Criterion

Open circuit output test voltage and repetition rate of the impulses					
Level	On powe	er port, PE	On I/O (input/output) signal, data and control ports		
Level	Voltage peak kV	Repetition rate kHz	Voltage peak kV	Repetition rate kHz	
1.	0.5	5 or 100	0.25	5 or 100	
2.	1	5 or 100	0.5	5 or 100	
3.	2	5 or 100	1	5 or 100	
4.	4	5 or 100	2	5 or 100	
X ^a	Special Special Special Special				
X:SpecialSpecialSpecialNote 1:Use of 5kHz repetition rates is traditional; however, 100kHz is closer to reality. Product committees should determine which frequencies are relevant for specific products or product types.Note 2:With some products, there may be no clear distinction between power ports and I/O ports, in which case it is up to product committees to make this determination for test purposes.a "X" is an open level. The level has to be specified in the dedicated					
6	equipment specif	fication.			

9.4 EUT Configuration

The configuration of the EUT is same as those used in conducted disturbance test. Refer to Sec. 4.4.

9.5 Operating Condition of EUT

- 9.5.1 Setup the EUT on the table in a shielded room as Sec. 9.1.1.
- 9.5.2 The test voltage was coupled to AC mains of the EUT.
- 9.5.3 Check the effects of the test.

9.6 Test Procedure

The EUT was placed upon a wooden table, 0.8 m high, standing on the ground reference plane, which is a 2 m \times 3 m metallic sheet with 1.5 mm thickness. This ground reference plane projected beyond the EUT by at least 0.1 m on all sides and the minimum distance between the EUT and all other conductive structure, except the ground plane beneath the EUT, was more than 0.5 m.

9.6.1 For input and output AC power ports:

The EUT was connected to the power mains by using a coupling device, which coupled the EFT interference signal to AC power lines.

9.7 Test Results

<PASS>

Electrical Fast Transient/Burst Immunity Test Result

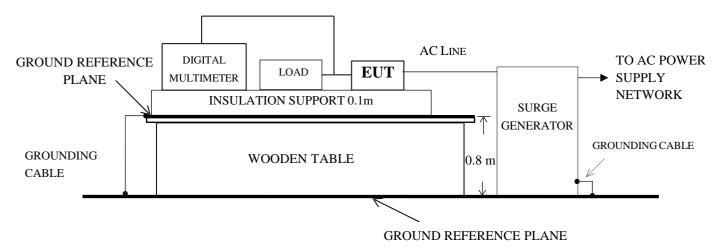
			Test Dat	e :	Jul 12, 2	2012
EUT :	Switching Power Supply		Tomporatura			
M/N :	AK25W-SSM-5, AK25W-SSM-24, AK25W-SSM-48		Temperature: $23^{\circ}C$ Humidity: $55\%R$		55%RH	ł
S/N :	E1207849-02/03, E1207849-03/03, E1207849-01/03		Atmospheric 101.3 kPa		a	
Power Supply :	AC 230V/50Hz		Pressure	2		
Test Mode :	Full Load		Inject Pl	ace :	<u>AC Ma</u>	ins
Inject Line	Voltage (kV)	Duration (s		Inject M	ethod	Result
L	±1	12	20	Dire	ct	A/PASS
N	±1	12	20	Direct		A/PASS
PE	±1	12	20	Dire	ct	A/PASS
L · N	±1	12	20	Dire	ct	A/PASS
L 、 PE	±1	12	20	Direct		A/PASS
N v PE	±1	12	20	Direct		A/PASS
$L \cdot N \cdot PE$	±1	12	20	Direct		A/PASS
DC Supply			-			
Signal Line						
NOTE 1 – "" means the item is no applicable. NOTE 2 – During the test, the maximum output voltage variation was < 1%.						
Test equipment: EFT Generator : Digital Multimeter : Agilent 34401A						

TEST ENGINEER: LVY LV

10 SURGE IMMUNITY TEST

10.1 Block Diagram of Test Setup

10.1.1 Surge Immunity test setup



Remark: Combination wave generator and decoupling networks are included in test.

10.2 Applicable Standard

EN 55024:2010 (CISPR 24:2010) (IEC 61000-4-5: 2005, Test Specification : AC Mains: Line to line: 0.5kV & 1.0kV; Line to Earth: 0.5kV, 1.0kV & 2.0kV)

10.3 Severity Levels and Performance Criterion

Test Level	Power supply Coupling mode			
	Line to line kV	Line to earth kV		
1	NA	0.5		
2	0.5	1.0		
3	1.0	2.0		
4	2.0	4.0		
X	Special	Special		

10.3.2 Performance criterion: B

10.4 EUT Configuration

The configuration of the EUT is same as those used in conducted disturbance test. Refer to Sec. 4.4.

10.5 Operating Condition of EUT

10.5.1 Setup the EUT on the table in the shielded room as Sec. 10.1.1.

10.5.2 Provide the voltage surge to the AC mains.

10.5.3 Check the effects of the test.

10.6 Test Procedure

For line to line coupling mode, provide a 0.5kV & 1kV surge (at open-circuit condition) to the EUT AC mains. The generator with its effective output impedance of 2Ω is used.

For line to earth coupling mode, provide 0.5kV, 1kV & 2kV surge (at open-circuit condition) to the EUT AC mains. The generator with its effective output impedance of 12Ω is used.

Such surge is a $1.2/50\mu$ s voltage surge at open-circuit condition, and an $8/20\mu$ s current surge into a short circuit.

At least five positive and five negative (polarity) tests with a maximum 1/min repetition rate during test.

Different phase angles were done individually.

10.7 Test Results

<PASS>

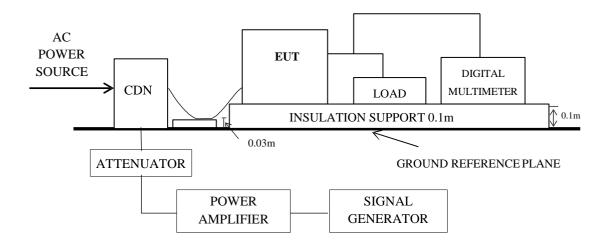
Surge Immunity Test Result

		Switching Power Supply			Test Date :	Jul 12, 2012		
EUT		-	_	oply	Temperature :	23°C		
M/N	: A	AK25W-SSM-5, AK25W-SSM-24, <u>AK25W-SSM-48</u>		Humidity :	55%RH			
S/N	: E	E1207849-02/03, E1207849-03/03, E1207849-01/03		Atmospheric Pressure :	101.3 kPa			
Power Supply	: <u>AC</u>	230V/50)Hz					
Power Supply : <u>AC 230V/50Hz</u> Test Mode : Full Load				Inject Place :	AC Mains			
				AC Input Powe	r Port			
Location		Pola	arity	Phase Angle	No. of Pulse	Pulse Voltage (kV)	Result	
		+	-	0	5	0.5 & 1	A/PASS	
L-N		+	-	90	5	0.5 & 1	A/PASS	
L-1N		+	-	180	5	0.5 & 1	A/PASS	
		+	-	270	5	0.5 & 1	A/PASS	
		+	-	0	5	0.5, 1 & 2	A/PASS	
L-PE		+	-	90	5	0.5, 1 & 2	A/PASS	
L-FE		+	-	180	5	0.5, 1 & 2	A/PASS	
		+	-	270	5	0.5, 1 & 2	A/PASS	
		+	-	0	5	0.5, 1 & 2	A/PASS	
NIDE		+	-	90	5	0.5, 1 & 2	A/PASS	
N-PE		+	-	180	5	0.5, 1 & 2	A/PASS	
		+	-	270	5	0.5, 1 & 2	A/PASS	
g. 11.		+	-	L-PE				
Signal Line		+	-	L-L				
	NOTE – During the test, the maximum output voltage variation of AK25W-SSM-5 was < 2%; the maximum output voltage variation of AK25W-SSM-24 and AK25W-SSM-48 was <							
Test	4 -							
□ Surge	Test equipment: Image: Surge Generator : Prima SUG61005B Image: Digital Multimeter : Agilent 34401A							

11 CONDUCTED DISTURBANCES IMMUNITY TEST

11.1 Block Diagram of Test Setup

11.1.1 Conducted Disturbances Immunity test setup



11.2 Applicable Standard

EN 55024:2010 (CISPR 24:2010) (IEC 61000-4-6: 2008, Test Specification : 0.15-80MHz, 3V, 80% AM (1kHz))

11.3 Severity Levels and Performance Criterion

1.5								
	Frequency Range 0.15 MHz – 80 MHz							
	Level	Voltage Level (e.m.f.)						
		$U_0 dB(\mu V)$	$\mathrm{U}_{0}\left(\mathrm{V} ight)$					
	1.	120	1					
	2.	130	3					
	3.	140	10					
	Х	Special						

11.3.1 Severity levels

11.3.2 Performance criterion: A

11.4 EUT Configuration

The configuration of the EUT is same as those used in conducted disturbance test. Refer to Sec. 4.4.

11.5 Operating Condition of EUT

- 11.5.1 Setup the EUT and load on the table as Sec.11.1, and operated them as Sec.4.5.
- 11.5.2 Inject the disturbance signal to the EUT AC mains through CDN.
- 11.5.3 Check the effects of the test.

11.6 Test Procedure

The EUT was placed on a wooden table 0.1m above a ground reference plane. Cables between CDN and the EUT are as short as possible, and their height above the ground reference plane is 0.03 m.

The disturbance signal was injected to the AC input port of EUT through CDN.

The frequency range is swept from 150 kHz to 80 MHz using 3V signal level, and with the disturbance signal 80% amplitude modulated with a 1 kHz sine wave.

Remarks

All the scanning conditions are as follows:

Condition of Test

Fielded Strength Modulation Scanning Frequency Dwell Time 3 V (Severity Level 2) 80% AM 1 kHz 0.15 - 80 MHz 3 sec.

11.7 Test Results

<PASS>

Conducted Disturbances Immunity Test Result Audix Technology (Shanghai) Co., Ltd.

			Test Date :	Jul 05, 2012	
EUT	:	Switching Power Supply	Temperature :	22°C	
M/N	:	AK25W-SSM-5, AK25W-SSM-24, AK25W-SSM-48	Humidity:	50%RH	
S/N	:	E1207849-02/03, E1207849-03/03, E1207849-01/03	Atmospheric Pressure :	101.3 kPa	
Power Supply	:	AC 230V/50Hz	Steps :	1%	
Test Mode	:	Full Load	Modulation :	None 🗆 Pulse 🗖	80% AM 1kHz
Frequency Range (MHz) Injected Pos		Injected Position	Strength (Unmodulated)	Criterion	Results
0.15 ~ 80		AC Mains	3V(r.m.s.)	А	PASS
NOTE – Dur	ing	the test, the output has no char	nge.		
Test equipme Signal CDN Power Attenua Power Power Digital	Ger Am ator Met Sen	: FCC-801- plifier : AR 100A : WC 40-6- ter: : HP 438A	-M3-25 .250 -34 B		

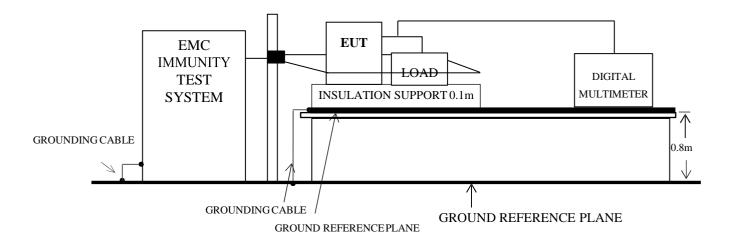
TEST ENGINEER: VINCENT GAO

12 POWER FREQUENCY MAGNETIC FIELD IMMUNITY

TEST

12.1 Block Diagram of Test Setup

12.1.1 Power Frequency Magnetic Field Immunity test setup



12.2 Applicable Standard

EN 55024:2010 (CISPR 24:2010) (IEC 61000-4-8: 2009, Magnetic field strength: 1A/m)

12.3 Severity Levels and Performance Criterion

12.3.1 Severity level:

Test Level	Magnetic field strength A/m
1	1
2	3
3	10
4	30
5	100
X	Special

12.3.2 Performance criterion: A

12.4 EUT Configuration

The configuration of the EUT is same as those used in conducted disturbance test. Refer to Sec. 4.4.

12.5 Operating Condition of EUT

Same as conducted measurement, which is listed in 4.5 except for the test set up that replaced by section 12.1.1.

12.6 Test Procedure

The EUT placed on high 1m table that above the ground reference plane which the min. size $1m \times 2m$ and 1.2mm thickness metallic, and subjected to the test magnetic field by using the induction coil of standard dimensions $(1m \times 1m)$. The induction coil rotated by 90 degrees in order to expose the EUT to the test field with different orientations. All cables of EUT exposed to magnetic field for 1m of their length.

12.7 Test Results

<PASS>

Power Frequency Magnetic Field Immunity Test Result Audix Technology (Shanghai) Co., Ltd.

EUT :	Switching Power Supply	Test Date	:	Jul 12, 2012			
M/N :	AK25W-SSM-5, AK25W -SSM-24, AK25W -SSM-48	Temperature	: _	23°C			
S/N :	_AK25W <u>-SSM-48</u> E1207849-02/03, : E1207849-03/03,		ty : 55%RH				
Power Supply :	E1207849-01/03 AC 230V/50Hz	Atmospheric Pressure	: _	101.3 kPa			
		Test Mode	:	Full Load			
Test Level (A/m)	Testing Duration (in second)	Coil Orientation	Cri	iterion	Result		
1	120	Axis-X		Α	PASS		
1	120	Axis-Y		A	PASS		
1	120	Axis-Z		A	PASS		
NOTE – During th	NOTE – During the test, the maximum output voltage variation was $< 0.2\%$.						
Test Instrumentation: P-f Magnetic Field Loop : FCC F-1000-4-8/9/10-1M EMC Immunity Test System : KeyTek CE Master Digital Multimeter : Agilent 34401A							

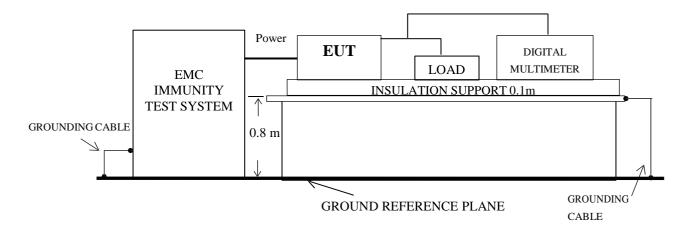
TEST ENGINEER: LVY LV

13 VOLTAGE DIPS AND SHORT INTERRUPTIONS

IMMUNITY TEST

13.1 Block Diagram of Test Setup

13.1.1 Voltage Dips and Short Interruptions Immunity test setup



13.2 Applicable Standard

EN 55024:2010 (CISPR 24:2010)

(IEC 61000-4-11:2004, Test Specification : Voltage dips, >95% reduction; Voltage dips, 30% reduction; Voltage interruptions)

13.3 Severity Levels and Performance Criterion

13.3.1	Preferred	severity	levels and	durations	for v	oltage dips
--------	-----------	----------	------------	-----------	-------	-------------

Class ^a	Test level and durations for voltage dips (t _s) (50Hz/60Hz)						
Class 1	Cas	Case-by-case according to the equipment requirements					
Class 2	0% during ¹ / ₂ cycle	0% during 1 cycle	70% during 25/30 ^c cycles				
Class 3	0% during ¹ / ₂ cycle	0% during 1 cycle	40% during 10/12 ^c cycles	70% during 25/30 ^c cycles	80% during 250/300 ^c cycles		
Class X ^b	Х	Х	Х	Х	Х		
_							

^a Classes as per IEC 61000-2-4.

^b To be defined by product committee. For equipment connected directly or indirectly to the public network, the levels must not be less severe than Class 2.

^c "25/30 cycles" means "25 cycles for 50Hz test" and "30 cycles for 60Hz test".

13.3.2 Preferred severity levels and durations for short interruptions:

Class ^a	Test level and durations for short interruptions (t_s) (50Hz/60Hz)					
Class 1	Case-by-case according to the equipment requirements					
Class 2	0% during 250/300 ^c cycles					
Class 3	80% during 250/300 ^c cycles					
Class X ^b	Х					
 ^a Classes as per IEC 61000-2-4. ^b To be defined by product committee. For equipment connected directly or indirectly to the public network, the levels must not be less severe than Class 2. 						

^c "250/300 cycles" means "250 cycles for 50Hz test" and "300 cycles for 60Hz test".

13.4 EUT Configuration

The configuration of the EUT is same as those used in conducted disturbance test. Refer to Sec. 4.4.

13.5 Operating Condition of EUT

13.5.1 Setup the EUT on the table in a shielded room as Sec. 13.1.1.

13.5.2 Provide the interruptions and voltage dips to the EUT AC mains.

13.5.3 Check the effects of the test.

13.6 Test Procedure

The EUT was placed upon a wooden table, 0.8 m above the ground.

The short interruptions and voltage dips were introduced at selected phase angles with specified duration. There were three dips/interruptions with interval of 10s minimum between each test event. After each group of tests a full functional check was performed.

13.7 Test Results

<PASS>

Voltage Dips & Short Interruptions Immunity Test Result

			Test Date	: Jul 1	2, 2012		
EUT	: Switching Pow	ver Supply	Temperature	: 25°C			
M/N	AK25W-SSM : AK25W -SSM _AK25W <u>-SSM</u>	-24,	Humidity	: 53%	53%RH		
S/N	E1207849-02/03, : E1207849-03/03, E1207849-01/03		Atmospheric Pressure	: 101.3	101.3 k/Pa		
Power Supply	y: <u>100-240VAC~</u>	50/60Hz	Test Mode	: <u>Full L</u>	oad		
Test Voltage	: 100V~50/60Hz 240V~50/60Hz						
Test Level (%Ut)	Voltage Dips & Short Interruptions (%Ut)	Duration (in period)	Phase (In Angle)	Criterion	Voltage phenomenon	Result	
70	30	25P	0°, 45°, 90°, 135 °, 180°, 225°, 270°, 315°	С	Dips	A/PASS	
0	100	0.5P	0°, 45°, 90°, 135 °, 180°, 225°, 270°, 315°	В	Dips	A/PASS	
0	100	250P	0°, 45°, 90°, 135 °, 180°, 225°, 270°, 315°	С	Interruptions	B/PASS	
NOTE 1 – "P" means period (20ms). NOTE 2 – B means during the level 100%, dip 250P test, the EUT will restart. NOTE 3 – During the other levels of test, the maximum output voltage variation was < 0.5%.							
	nent: Immunity Test Syst Il Multimeter		yTek CE Master ilent 34401A				

TEST ENGINEER: LVY LV